Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/769,163	PLAZA, MANUEL ES	SLICK
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED				
Class	Subclass	Date	Examiner	
715	804	10/25/2007	LVN	

<u></u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	b, USPAT: /804	10/25/2007	LVN	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
US-PGPub, USPAT: 715/760,804,805	10/25/2007	LVN		
EPO, JPO	10/25/2007	LVN		
ACM library, IEEE Explore	10/25/2007	LVN		
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